Encyclopedia of Semiconductor Technology

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EDITORIAL STAFF

CONTRIBUTORS

J. H. Adams, *Eagle-Picher Industries, Inc., Quapaw, Oklahoma,* Germanium and germanium compounds

David Adler, *Massachusetts Institute of Technology, Cambridge Massachusetts,* Semiconductors, amorphous

Morton Antler, *Bell Telephone Laboratories, Columbus, Ohio,* Electrical connectors

Sebastian R. Borrello, *Texas Instruments Incorporated, Dallas, Texas,* Photodetectors

H. Kent Bowen, *Massachusetts Institute of Technology, Cambridge, Massachusetts,* Ceramics as electrical materials

James W. Butler, *Naval Research Laboratory, Washington, D.C.,* Ion implantation

S. C. Carapella, Jr., *ASARCO, Inc., South Plainfield, New Jersey,* Arsenic and arsenic alloys
Chuan C. Chang, *Bell Laboratories, Murray Hill, New Jersey,* Semiconductors, fabrication and characterization
G. Y. Chin, *Bell Telephone Laboratories, Murray Hill, New Jersey,* Magnetic materials, bulk and thin film
J. T. Clemens, *Bell Telephone Laboratories, Incorporated, Allentown, Pennsylvania,* Integrated circuits
L. E. Cross, *The Pennsylvania State University, University Park, Pennsylvania,* Ferroelectrics
Jesse H. Day, *Ohio University, Athens, Ohio,* Chromogenic materials, electrochromic and thermochromic
Pierre de la Brèteque, *Alusuisse France S.A., Marseille, France,* Gallium and gallium compounds
François M. d'Heurle, *IBM, Yorktown Heights, New York,* Electromigration
Charles B. Duke, *Xerox Corporation, Rochester, New York,* Polymers, conductive
Takeshi Egami, *Institut für Physik Max-Planck Institut für Metallforschung, Stuttgart, Federal Republic of Germany,* Glassy metals
E. M. Elkin, *Noranda Mines, Ltd., Montreal, Quebec, Canada,* Tellurium and tellurium compounds
John C. C. Fan, *Massachusetts Institute of Technology, Cambridge, Massachusetts,* Photovoltaic cells
William G. French, *3M Company, St. Paul, Minnesota,* Fiber optics
Harry W. Gibson, *Xerox Corporation, Rochester, New York,* Polymers, conductive
Alfred C. Glatz, *General Foods Corporation, Tarrytown, New York,* Thermoelectric energy conversion
Robert C. Haddon, *Bell Laboratories, Murray Hill, New Jersey,* Semiconductors, organic
Robert W. Haisty, *Texas Instruments Incorporated, Dallas, Texas,* Digital displays
K. H. Härdtl, *Philips Forschungslaboratorium, GmbH, Aschen, Federal Republic of Germany,* Ferroelectrics
Charles A. Harper, *Westinghouse Electric Corporation, Baltimore, Maryland,* Embedding
Martin L. Kaplan, *Bell Laboratories, Murray Hill, New Jersey,* Semiconductors, organic
Gerald A. Krulik, *Borg-Warner Corporation, Des Plaines, Illinois,* Electroless plating
E. F. Labuda, *Bell Telephone Laboratories, Incorporated, Allentown, Pennsylvania,* Integrated circuits
Leonard Lamberson, *Wayne State University, Detroit Michigan,* Materials reliability
Stuart M. Lee, *Ford Aerospace and Communications Corp., Palo Alto, California,* Film-deposition techniques
F. E. Luborsky, *General Electric Company, Schenectady, New York,* Amorphous magnetic materials
John B. MacChesney, *Bell Laboratories, Inc., Murray Hill, New Jersey,* Fiber optics
Frank P. Missell, *Universidade de São Paulo, São Paulo, Brazil,* Superconducting materials
Michel F. Molaire, *Eastman Kodak Company, Rochester, New York,* Photoreactive polymers
C. L. Newton, *Air Products and Chemicals, Inc., Allentown, Pennsylvania,* Cryogenics
A. A. Nishimura, *Ampex Corporation, Redwood City, California,* Magnetic tape
Morton B. Panish, *Bell Laboratories, Murray Hill, New Jersey,* Light-emitting diodes and semiconductor lasers

A. David Pearson, *Bell Laboratories, Inc., Murray Hill, New Jersey,* Fiber optics

P. Andrew Penz, *Texas Instruments Incorporated, Dallas, Texas,* Digital displays

R. H. Perry, *Ampex Corporation, Redwood City, California,* Magnetic tape

David T. Peterson, *Iowa State University, Ames, Iowa,* Electromigration

Thomas G. Reynolds, III, *Ferroxcube Corporation, Saugerties, New York,* Ferrites

Walter Runyan, *Texas Instruments, Inc., Dallas, Texas,* Silicon and silicon alloys, pure silicon

Brian B. Schwartz, *Brooklyn College, CUNY, Brooklyn, New York,* Superconducting materials

S. A. Schwarz, *Bell Laboratories, Inc., Murray Hill, New Jersey,* Semiconductors, theory and application

Kishin H. Surtani, *Texas Instruments Incorporated, Dallas, Texas,* Digital displays

John R. Van Wazer, *Vanderbilt University, Nashville, Tennessee,* Phosphorus and the phosphides

J. H. Wernick, *Bell Laboratories, Murray Hill, New Jersey,* Magnetic materials, bulk and thin film

Jack L. R. Williams, *Eastman Kodak Company, Rochester, New York,* Photoreactive polymers

Fred Wudl, *Bell Laboratories, Murray Hill, New Jersey,* Semiconductors, organic

PREFACE

This volume is another in the series of carefully selected reprints from the world-renowned Kirk-Othmer *Encyclopedia of Chemical Technology* designed to provide specific audiences with articles grouped by a central theme. Although the 25-volume Kirk-Othmer Encyclopedia is widely available, many readers and users of this key reference tool have expressed interest in having selected articles in their specialty collected for handy desk reference or teaching purposes. In response to this need, we have chosen all of the original, complete articles related to semiconductor technology to make up this new volume. The full texts, tables, figures and reference materials from the original work have been reproduced here unchanged. All articles are by industrial or academic experts in their field and the final work represents the result of careful review by competent specialists and the thorough editorial processing of the professional Wiley staff. Introductory information from the Encyclopedia concerning Chemical Abstracts Registry Numbers, nomenclature, SI units and conversion factors and related information has been provided as a further guide to the contents for those concerned with the materials aspects of semiconductors.

The contents of this volume include coverage of nearly every aspect of semiconductors and provide detailed information on methods of manufacture, properties and uses of semiconductors, common elements used in their manufacture, and related substances. Alphabetical organization, extensive cross references and a complete index further enhance the utility of this Encyclopedia. The approximately 37 main entries in the Encyclopedia each average 10,000 words in length and have been prepared by leading authorities from industries, universities and research institutes. The contents should be of interest to all those engaged in the manufacture and use of semiconductors, integrated circuits, magnetic materials, superconductors, etc, for use in electronics, computers, robotics, communications and related industrial activities. The contents range over such diverse fields as amorphous magnetic materials, arsenic and arsenic alloys, digital displays, fiber optics, integrated circuits, light-emitting diodes and semiconductor lasers; and semiconductors, theory, application, fabrication and characterization, amorphous semiconductors and semiconductors, organic. The book should be an important research reference tool, desk-top information resource, and supplementary reading asset for teaching professionals and their students.

M. GRAYSON

NOTE ON CHEMICAL ABSTRACTS SERVICE REGISTRY NUMBERS AND NOMENCLATURE

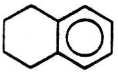
Chemical Abstracts Service (CAS) Registry Numbers are unique numerical identifiers assigned to substances recorded in the CAS Registry System. They appear in brackets in the *Chemical Abstracts* (CA) substance and formula indexes following the names of compounds. A single compound may have many synonyms in the chemical literature. A simple compound like phenethylamine can be named β-phenylethylamine or, as in *Chemical Abstracts*, benzeneethanamine. The usefulness of the *Encyclopedia* depends on accessibility through the most common correct name of a substance. Because of this diversity in nomenclature careful attention has been given the problem in order to assist the reader as much as possible, especially in locating the systematic CA index name by means of the Registry Number. For this purpose, the reader may refer to the CAS Registry Handbook-Number Section which lists in numerical order the Registry Number with the *Chemical Abstracts* index name and the molecular formula; eg, **458-88-8,** Piperidine, 2-propyl-, (*S*)-, $C_8H_{17}N$; in the *Encyclopedia* this compound would be found under its common name, coniine [*458-88-8*]. The Registry Number is a valuable link for the reader in retrieving additional published information on substances and also as a point of access for such on-line data bases as Chemline, Medline, and Toxline.

In all cases, the CAS Registry Numbers have been given for title compounds in articles and for all compounds in the index. All specific substances indexed in *Chemical Abstracts* since 1965 are included in the CAS Registry System as are a large number of substances derived from a variety of reference works. The CAS Registry System identifies a substance on the basis of an unambiguous computer-language description of its molecular structure including stereochemical detail. The Registry Number is a machine-checkable number (like a Social Security number) assigned in sequential order to each substance as it enters the registry system. The value of the number lies in the fact that it is a concise and unique means of substance identification, which is independent of, and therefore bridges, many systems of chemical nomenclature. For polymers, one Registry Number is used for the entire family; eg, polyoxyethylene (20) sorbitan monolaurate has the same number as all of its polyoxyethylene homologues.

Registry numbers for each substance will be provided in the third edition cumulative index and appear as well in the annual indexes (eg, Alkaloids shows the Registry Number of all alkaloids (title compounds) in a table in the article as well, but the intermediates have their Registry Numbers shown only in the index). Articles such as Analytical methods, Batteries and electric cells, Chemurgy, Distillation, Economic evaluation, and Fluid mechanics have no Registry Numbers in the text.

Cross-references are inserted in the index for many common names and for some systematic names. Trademark names appear in the index. Names that are incorrect, misleading or ambiguous are avoided. Formulas are given very frequently in the text to help in identifying compounds. The spelling and form used, even for industrial names, follow American chemical usage, but not always the usage of *Chemical Abstracts* (eg, *coniine* is used instead of (*S*)-*2-propylpiperidine*, *aniline* instead of *benzenamine*, and *acrylic acid* instead of *2-propenoic acid*).

There are variations in representation of rings in different disciplines. The dye industry does not designate aromaticity or double bonds in rings. All double bonds and aromaticity are shown in the *Encyclopedia* as a matter of course. For example, tetralin has an aromatic ring and a saturated ring and its structure appears in the



Encyclopedia with its common name, Registry Number enclosed in brackets, and parenthetical CA index name, ie, tetralin, [*119-64-2*] (1,2,3,4-tetrahydronaphthalene). With names and structural formulas, and especially with CAS Registry Numbers the aim is to help the reader have a concise means of substance identification.

CONVERSION FACTORS, ABBREVIATIONS, AND UNIT SYMBOLS

SI Units (Adopted 1960)

A new system of measurement, the International System of Units (abbreviated SI), is being implemented throughout the world. This system is a modernized version of the MKSA (meter, kilogram, second, ampere) system, and its details are published and controlled by an international treaty organization (The International Bureau of Weights and Measures) (1).

SI units are divided into three classes:

BASE UNITS

length	meter[†] (m)
mass[‡]	kilogram (kg)
time	second (s)
electric current	ampere (A)
thermodynamic temperature[§]	kelvin (K)
amount of substance	mole (mol)
luminous intensity	candela (cd)

SUPPLEMENTARY UNITS

plane angle	radian (rad)
solid angle	steradian (sr)

[†] The spellings "metre" and "litre" are preferred by ASTM; however "-er" are used in the Encyclopedia.

[‡] "Weight" is the commonly used term for "mass."

[§] Wide use is made of "Celsius temperature" (t) defined by

$$t = T - T_0$$

where T is the thermodynamic temperature, expressed in kelvins, and $T_0 = 273.15$ K by definition. A temperature interval may be expressed in degrees Celsius as well as in kelvins.

SUPPLEMENTARY UNITS

plane angle	radian (rad)
solid angle	steradian (sr)

DERIVED UNITS AND OTHER ACCEPTABLE UNITS

These units are formed by combining base units, supplementary units, and other derived units (2–4). Those derived units having special names and symbols are marked with an asterisk in the list below:

Quantity	*Unit*	*Symbol*	*Acceptable equivalent*
*absorbed dose	gray	Gy	J/kg
acceleration	meter per second squared	m/s^2	
*activity (of ionizing radiation source)	becquerel	Bq	1/s
area	square kilometer	km^2	
	square hectometer	hm^2	ha (hectare)
	square meter	m^2	
*capacitance	farad	F	C/V
concentration (of amount of substance)	mole per cubic meter	mol/m^3	
*conductance	siemens	S	A/V
current density	ampere per square meter	A/m^2	
density, mass density	kilogram per cubic meter	kg/m^3	g/L; mg/cm^3
dipole moment (quantity)	coulomb meter	C·m	
*electric charge, quantity of electricity	coulomb	C	A·s
electric charge density	coulomb per cubic meter	C/m^3	
electric field strength	volt per meter	V/m	
electric flux density	coulomb per square meter	C/m^2	
*electric potential, potential difference, electromotive force	volt	V	W/A
*electric resistance	ohm	Ω	V/A
*energy, work, quantity of heat	megajoule	MJ	
	kilojoule	kJ	
	joule	J	N·m
	electron volt†	eV†	
	kilowatt-hour†	kW·h†	

† This non-SI unit is recognized by the CIPM as having to be retained because of practical importance or use in specialized fields (1).

Quantity	*Unit*	*Symbol*	*Acceptable equivalent*
energy density	joule per cubic meter	J/m^3	
*force	kilonewton	kN	
	newton	N	$kg{\cdot}m/s^2$
*frequency	megahertz	MHz	
	hertz	Hz	1/s
heat capacity, entropy	joule per kelvin	J/K	
heat capacity (specific), specific entropy	joule per kilogram kelvin	J/(kg·K)	
heat transfer coefficient	watt per square meter kelvin	$W/(m^2{\cdot}K)$	
*illuminance	lux	lx	lm/m^2
*inductance	henry	H	Wb/A
linear density	kilogram per meter	kg/m	
luminance	candela per square meter	cd/m^2	
*luminous flux	lumen	lm	cd·sr
magnetic field strength	ampere per meter	A/m	
*magnetic flux	weber	Wb	V·s
*magnetic flux density	tesla	T	Wb/m^2
molar energy	joule per mole	J/mol	
molar entropy, molar heat capacity	joule per mole kelvin	J/(mol·K)	
moment of force, torque	newton meter	N·m	
momentum	kilogram meter per second	kg·m/s	
permeability	henry per meter	H/m	
permittivity	farad per meter	F/m	
*power, heat flow rate, radiant flux	kilowatt	kW	
	watt	W	J/s
power density, heat flux density, irradiance	watt per square meter	W/m^2	
*pressure, stress	megapascal	MPa	
	kilopascal	kPa	
	pascal	Pa	N/m^2
sound level	decibel	dB	
specific energy	joule per kilogram	J/kg	
specific volume	cubic meter per kilogram	m^3/kg	
surface tension	newton per meter	N/m	
thermal conductivity	watt per meter kelvin	W/(m·K)	
velocity	meter per second	m/s	
	kilometer per hour	km/h	
viscosity, dynamic	pascal second	Pa·s	
	millipascal second	mPa·s	
viscosity, kinematic	square meter per second	m^2/s	

Quantity	*Unit*	*Symbol*	*Acceptable equivalent*
	square millimeter per second	mm^2/s	
volume	cubic meter	m^3	
	cubic decimeter	dm^3	L(liter) (5)
	cubic centimeter	cm^3	mL
wave number	1 per meter	m^{-1}	
	1 per centimeter	cm^{-1}	

In addition, there are 16 prefixes used to indicate order of magnitude, as follows:

Multiplication factor	*Prefix*	*Symbol*	*Note*
10^{18}	exa	E	
10^{15}	peta	P	
10^{12}	tera	T	
10^{9}	giga	G	
10^{6}	mega	M	
10^{3}	kilo	k	
10^{2}	hecto	h[a]	[a] Although hecto, deka, deci, and centi are SI prefixes, their use should be avoided except for SI unit-multiples for area and volume and nontechnical use of centimeter, as for body and clothing measurement.
10	deka	da[a]	
10^{-1}	deci	d[a]	
10^{-2}	centi	c[a]	
10^{-3}	milli	m	
10^{-6}	micro	μ	
10^{-9}	nano	n	
10^{-12}	pico	p	
10^{-15}	femto	f	
10^{-18}	atto	a	

For a complete description of SI and its use the reader is referred to ASTM E 380 (4) and the article Units and Conversion Factors which will appear in a later volume of the *Encyclopedia.*

A representative list of conversion factors from non-SI to SI units is presented herewith. Factors are given to four significant figures. Exact relationships are followed by a dagger. A more complete list is given in ASTM E 380-79(4) and ANSI Z210.1-1976 (6).

Conversion Factors to SI Units

To convert from	*To*	*Multiply by*
acre	square meter (m^2)	4.047×10^{3}
angstrom	meter (m)	1.0×10^{-10}†
are	square meter (m^2)	1.0×10^{2}†
astronomical unit	meter (m)	1.496×10^{11}
atmosphere	pascal (Pa)	1.013×10^{5}
bar	pascal (Pa)	1.0×10^{5}†
barn	square meter (m^2)	1.0×10^{-28}†

† Exact.

To convert from	*To*	*Multiply by*
barrel (42 U.S. liquid gallons)	cubic meter (m^3)	0.1590
Bohr magneton (μ_β)	J/T	9.274×10^{-24}
Btu (International Table)	joule (J)	1.055×10^{3}
Btu (mean)	joule (J)	1.056×10^{3}
Btu (thermochemical)	joule (J)	1.054×10^{3}
bushel	cubic meter (m^3)	3.524×10^{-2}
calorie (International Table)	joule (J)	4.187
calorie (mean)	joule (J)	4.190
calorie (thermochemical)	joule (J)	4.184†
centipoise	pascal second (Pa·s)	1.0×10^{-3}†
centistoke	square millimeter per second (mm^2/s)	1.0†
cfm (cubic foot per minute)	cubic meter per second (m^3/s)	4.72×10^{-4}
cubic inch	cubic meter (m^3)	1.639×10^{-5}
cubic foot	cubic meter (m^3)	2.832×10^{-2}
cubic yard	cubic meter (m^3)	0.7646
curie	becquerel (Bq)	3.70×10^{10}†
debye	coulomb·meter (C·m)	3.336×10^{-30}
degree (angle)	radian (rad)	1.745×10^{-2}
denier (international)	kilogram per meter (kg/m)	1.111×10^{-7}
	tex‡	0.1111
dram (apothecaries')	kilogram (kg)	3.888×10^{-3}
dram (avoirdupois)	kilogram (kg)	1.772×10^{-3}
dram (U.S. fluid)	cubic meter (m^3)	3.697×10^{-6}
dyne	newton (N)	1.0×10^{-5}†
dyne/cm	newton per meter (N/m)	1.0×10^{-3}†
electron volt	joule (J)	1.602×10^{-19}
erg	joule (J)	1.0×10^{-7}†
fathom	meter (m)	1.829
fluid ounce (U.S.)	cubic meter (m^3)	2.957×10^{-5}
foot	meter (m)	0.3048†
footcandle	lux (lx)	10.76
furlong	meter (m)	2.012×10^{-2}
gal	meter per second squared (m/s^2)	1.0×10^{-2}†
gallon (U.S. dry)	cubic meter (m^3)	4.405×10^{-3}
gallon (U.S. liquid)	cubic meter (m^3)	3.785×10^{-3}
gallon per minute (gpm)	cubic meter per second (m^3/s)	6.308×10^{-5}
	cubic meter per hour (m^3/h)	0.2271
gauss	tesla (T)	1.0×10^{-4}
gilbert	ampere (A)	0.7958
gill (U.S.)	cubic meter (m^3)	1.183×10^{-4}
grad	radian	1.571×10^{-2}
grain	kilogram (kg)	6.480×10^{-5}
gram force per denier	newton per tex (N/tex)	8.826×10^{-2}

† Exact.

‡ See footnote on p. xiv.

To convert from	*To*	*Multiply by*
hectare	square meter (m^2)	$1.0 \times 10^{4\dagger}$
horsepower (550 ft·lbf/s)	watt (W)	7.457×10^2
horsepower (boiler)	watt (W)	9.810×10^3
horsepower (electric)	watt (W)	$7.46 \times 10^{2\dagger}$
hundredweight (long)	kilogram (kg)	50.80
hundredweight (short)	kilogram (kg)	45.36
inch	meter (m)	$2.54 \times 10^{-2\dagger}$
inch of mercury (32°F)	pascal (Pa)	3.386×10^3
inch of water (39.2°F)	pascal (Pa)	2.491×10^2
kilogram force	newton (N)	9.807
kilowatt hour	megajoule (MJ)	$3.6^\dagger$
kip	newton (N)	4.48×10^3
knot (international)	meter per second (m/s)	0.5144
lambert	candela per square meter (cd/m^2)	3.183×10^3
league (British nautical)	meter (m)	5.559×10^3
league (statute)	meter (m)	4.828×10^3
light year	meter (m)	9.461×10^{15}
liter (for fluids only)	cubic meter (m^3)	$1.0 \times 10^{-3\dagger}$
maxwell	weber (Wb)	$1.0 \times 10^{-8\dagger}$
micron	meter (m)	$1.0 \times 10^{-6\dagger}$
mil	meter (m)	$2.54 \times 10^{-5\dagger}$
mile (statute)	meter (m)	1.609×10^3
mile (U.S. nautical)	meter (m)	$1.852 \times 10^{3\dagger}$
mile per hour	meter per second (m/s)	0.4470
millibar	pascal (Pa)	1.0×10^2
millimeter of mercury (0°C)	pascal (Pa)	$1.333 \times 10^{2\dagger}$
minute (angular)	radian	2.909×10^{-4}
myriagram	kilogram (kg)	10
myriameter	kilometer (km)	10
oersted	ampere per meter (A/m)	79.58
ounce (avoirdupois)	kilogram (kg)	2.835×10^{-2}
ounce (troy)	kilogram (kg)	3.110×10^{-2}
ounce (U.S. fluid)	cubic meter (m^3)	2.957×10^{-5}
ounce-force	newton (N)	0.2780
peck (U.S.)	cubic meter (m^3)	8.810×10^{-3}
pennyweight	kilogram (kg)	1.555×10^{-3}
pint (U.S. dry)	cubic meter (m^3)	5.506×10^{-4}
pint (U.S. liquid)	cubic meter (m^3)	4.732×10^{-4}
poise (absolute viscosity)	pascal second (Pa·s)	$0.10^\dagger$
pound (avoirdupois)	kilogram (kg)	0.4536
pound (troy)	kilogram (kg)	0.3732
poundal	newton (N)	0.1383
pound-force	newton (N)	4.448
pound per square inch (psi)	pascal (Pa)	6.895×10^3
quart (U.S. dry)	cubic meter (m^3)	1.101×10^{-3}

† Exact.

To convert from	*To*	*Multiply by*
quart (U.S. liquid)	cubic meter (m^3)	9.464×10^{-4}
quintal	kilogram (kg)	$1.0 \times 10^{2\dagger}$
rad	gray (Gy)	$1.0 \times 10^{-2\dagger}$
rod	meter (m)	5.029
roentgen	coulomb per kilogram (C/kg)	2.58×10^{-4}
second (angle)	radian (rad)	4.848×10^{-6}
section	square meter (m^2)	2.590×10^{6}
slug	kilogram (kg)	14.59
spherical candle power	lumen (lm)	12.57
square inch	square meter (m^2)	6.452×10^{-4}
square foot	square meter (m^2)	9.290×10^{-2}
square mile	square meter (m^2)	2.590×10^{6}
square yard	square meter (m^2)	0.8361
stere	cubic meter (m^3)	$1.0^{\dagger}$
stokes (kinematic viscosity)	square meter per second (m^2/s)	$1.0 \times 10^{-4\dagger}$
tex	kilogram per meter (kg/m)	$1.0 \times 10^{-6\dagger}$
ton (long, 2240 pounds)	kilogram (kg)	1.016×10^{3}
ton (metric)	kilogram (kg)	$1.0 \times 10^{3\dagger}$
ton (short, 2000 pounds)	kilogram (kg)	9.072×10^{2}
torr	pascal (Pa)	1.333×10^{2}
unit pole	weber (Wb)	1.257×10^{-7}
yard	meter (m)	$0.9144^{\dagger}$

Abbreviations and Unit Symbols

Following is a list of commonly used abbreviations and unit symbols appropriate for use in the *Encyclopedia.* In general they agree with those listed in *American National Standard Abbreviations for Use on Drawings and in Text* (*ANSI Y1.1*) (6) and *American National Standard Letter Symbols for Units in Science and Technology* (*ANSI Y10*) (6). Also included is a list of acronyms for a number of private and government organizations as well as common industrial solvents, polymers, and other chemicals.

Rules for Writing Unit Symbols (4):

1. Unit symbols should be printed in upright letters (roman) regardless of the type style used in the surrounding text.

2. Unit symbols are unaltered in the plural.

3. Unit symbols are not followed by a period except when used as the end of a sentence.

4. Letter unit symbols are generally written in lower-case (eg, cd for candela) unless the unit name has been derived from a proper name, in which case the first letter of the symbol is capitalized (W,Pa). Prefix and unit symbols retain their prescribed form regardless of the surrounding typography.

5. In the complete expression for a quantity, a space should be left between the numerical value and the unit symbol. For example, write 2.37 lm, *not* 2.37lm, and 35 mm, *not* 35mm. When the quantity is used in an adjectival sense, a hyphen is often used, for example, 35-mm film. *Exception:* No space is left between the numerical value and the symbols for degree, minute, and second of plane angle, and degree Celsius.